

# LM837

## Low Noise Quad Operational Amplifier

### General Description

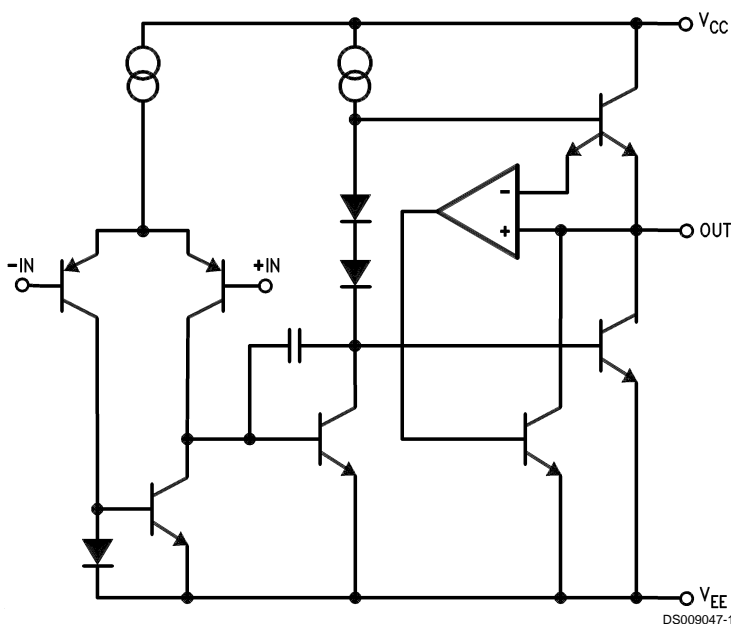
The LM837 is a quad operational amplifier designed for low noise, high speed and wide bandwidth performance. It has a new type of output stage which can drive a  $600\Omega$  load, making it ideal for almost all digital audio, graphic equalizer, preamplifiers, and professional audio applications. Its high performance characteristics also make it suitable for instrumentation applications where low noise is the key consideration.

The LM837 is internally compensated for unity gain operation. It is pin compatible with most other standard quad op amps and can therefore be used to upgrade existing systems with little or no change.

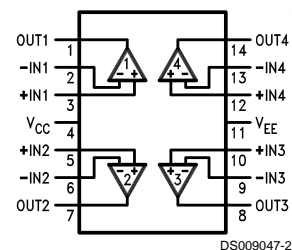
### Features

- High slew rate 10 V/ $\mu$ s (typ); 8 V/ $\mu$ s (min)
- Wide gain bandwidth product 25 MHz (typ); 15 MHz (min)
- Power bandwidth 200 kHz (typ)
- High output current  $\pm 40$  mA
- Excellent output drive performance  $> 600\Omega$
- Low input noise voltage 4.5 nV/ $\sqrt{\text{Hz}}$
- Low total harmonic distortion 0.0015%
- Low offset voltage 0.3 mV

### Schematic and Connection Diagrams



Dual-In-Line Package



**Top View**  
**Order Number LM837M,**  
**LM837MX or LM837N**  
**See NS Package Number**  
**M14A or N14A**

**Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage, $V_{CC}/V_{EE}$	$\pm 18V$
Differential Input Voltage, $V_{ID}$ (Note 2)	$\pm 30V$
Common Mode Input Voltage, $V_{IC}$ (Note 2)	$\pm 15V$
Power Dissipation, $P_D$ (Note 3)	1.2W (N) 830 mW (M)
Operating Temperature Range, $T_{OPR}$	$-40^{\circ}C$ to $+85^{\circ}C$

Storage Temperature Range,  $T_{STG}$   $-60^{\circ}C$  to  $+150^{\circ}C$

**Soldering Information**

Dual-In-Line Package	
Soldering (10 seconds)	$260^{\circ}C$
Small Outline Package	
Vapor Phase (60 seconds)	$215^{\circ}C$
Infrared (15 seconds)	$220^{\circ}C$

ESD rating to be determined.

See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" for other methods of soldering surface mount devices.

**DC Electrical Characteristics**

$T_A = 25^{\circ}C$ ,  $V_S = \pm 15V$

Symbol	Parameter	Condition	Min	Typ	Max	Units
$V_{OS}$	Input Offset Voltage	$R_S = 50\Omega$		0.3	5	mV
$I_{OS}$	Input Offset Current			10	200	nA
$I_B$	Input Bias Current			500	1000	nA
$A_V$	Large Signal Voltage Gain	$R_L = 2\text{ k}\Omega$ , $V_{OUT} = \pm 10V$	90	110		dB
$V_{OM}$	Output Voltage Swing	$R_L = 2\text{ k}\Omega$	$\pm 12$	$\pm 13.5$		V
		$R_L = 600\Omega$	$\pm 10$	$\pm 12.5$		V
$V_{CM}$	Common Mode Input Voltage		$\pm 12$	$\pm 14.0$		V
CMRR	Common Mode Rejection Ratio	$V_{IN} = \pm 12V$	80	100		dB
PSRR	Power Supply Rejection Ratio	$V_S = 15 \sim 5, -15 \sim -5$	80	100		dB
$I_S$	Power Supply Current	$R_L = \infty$ , Four Amps		10	15	mA

**AC Electrical Characteristics**

$T_A = 25^{\circ}C$ ,  $V_S = \pm 15V$

Symbol	Parameter	Condition	Min	Typ	Max	Units
SR	Slew Rate	$R_L = 600\Omega$	8	10		V/ $\mu s$
GBW	Gain Bandwidth Product	$f = 100\text{ kHz}$ , $R_L = 600\Omega$	15	25		MHz

**Design Electrical Characteristics**

$T_A = 25^{\circ}C$ ,  $V_S = \pm 15V$  (Note 4)

Symbol	Parameter	Condition	Min	Typ	Max	Units
PBW	Power Bandwidth	$V_O = 25\text{ V}_{P-P}$ , $R_L = 600\Omega$ , THD < 1%		200		kHz
$e_{n1}$	Equivalent Input Noise Voltage	JIS A, $R_S = 100\Omega$		0.5		$\mu V$
$e_{n2}$	Equivalent Input Noise Voltage	$f = 1\text{ kHz}$		4.5		$nV/\sqrt{Hz}$
$i_n$	Equivalent Input Noise Current	$f = 1\text{ kHz}$		0.7		$pA/\sqrt{Hz}$
THD	Total Harmonic Distortion	$A_V = 1$ , $V_{OUT} = 3\text{ V}_{rms}$ , $f = 20 \sim 20\text{ kHz}$ , $R_L = 600\Omega$		0.0015		%
$f_U$	Zero Cross Frequency	Open Loop		12		MHz
$\phi_m$	Phase Margin	Open Loop		45		deg
	Input-Referred Crosstalk	$f = 20 \sim 20\text{ kHz}$		-120		dB
$\Delta V_{OS}/\Delta T$	Average TC of Input Offset Voltage			2		$\mu V/^{\circ}C$

**Note 1:** Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which guarantee specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not guaranteed for parameters where no limit is given, however, the typical value is a good indication of device performance.

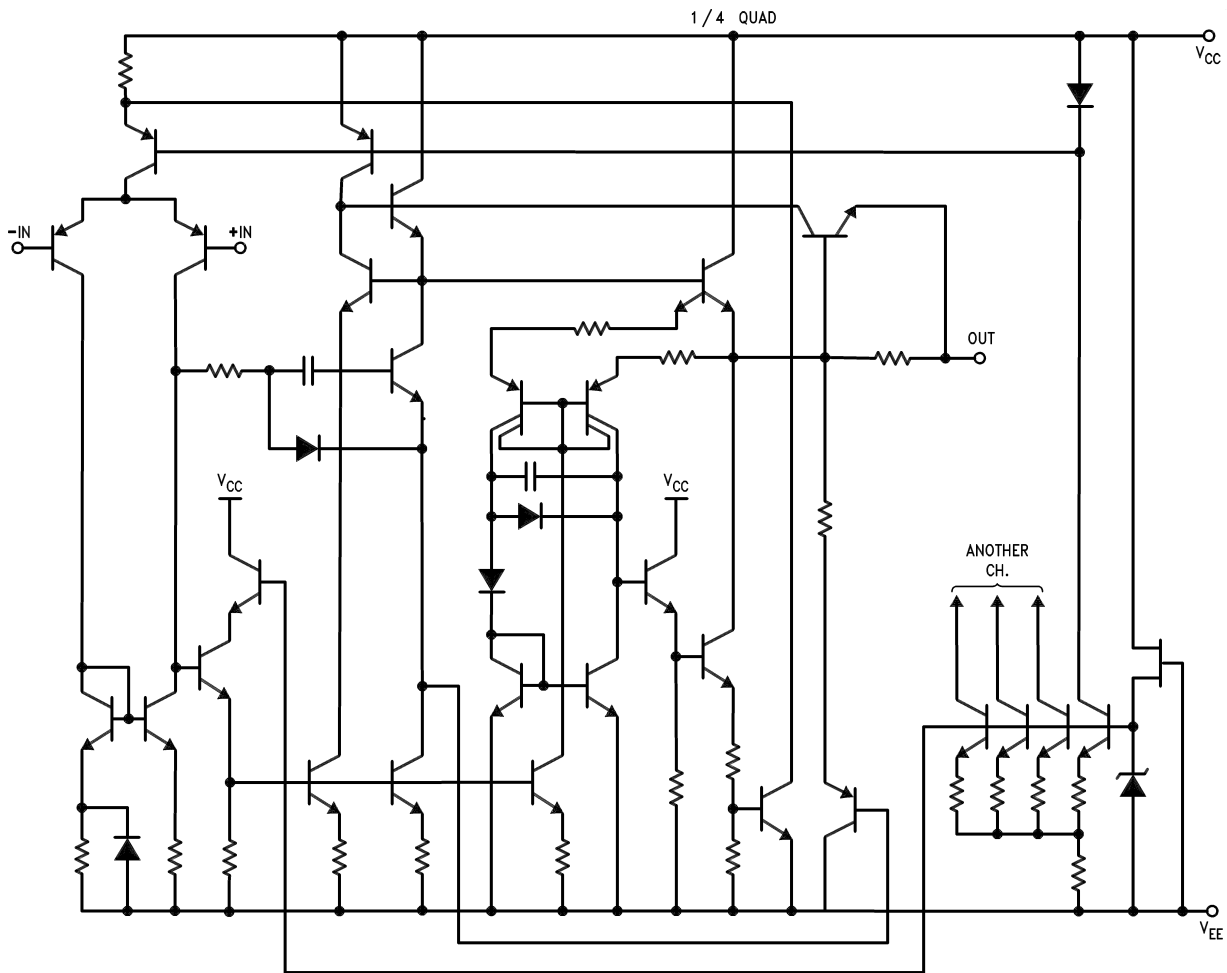
**Note 2:** Unless otherwise specified the absolute maximum input voltage is equal to the power supply voltage.

## Design Electrical Characteristics (Continued)

**Note 3:** For operation at ambient temperatures above 25°C, the device must be derated based on a 150°C maximum junction temperature and a thermal resistance, junction to ambient, as follows: LM837N, 90°C/W; LM837M, 150°C/W.

**Note 4:** The following parameters are not tested or guaranteed.

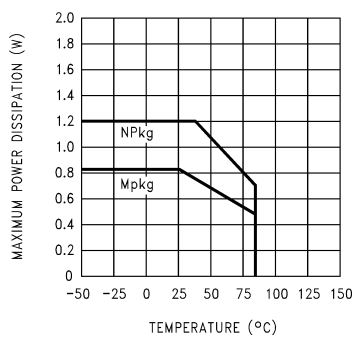
## Detailed Schematic



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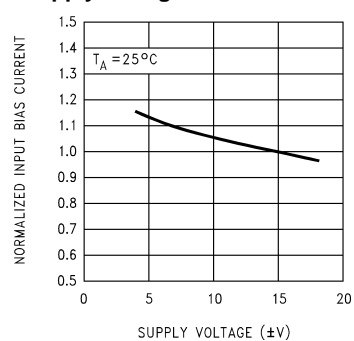
## Typical Performance Characteristics

**Maximum Power Dissipation vs Ambient Temperature**



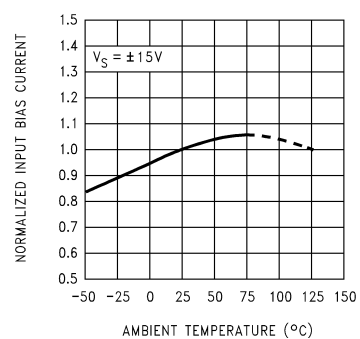
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**Normalized Input Bias Current vs Supply Voltage**



DS009047-11

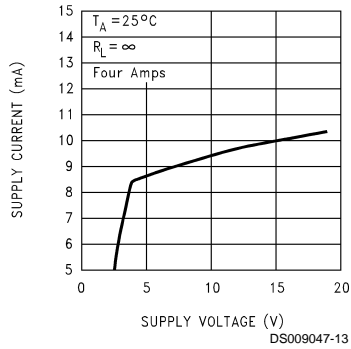
**Normalized Input Bias Current vs Ambient Temperature**



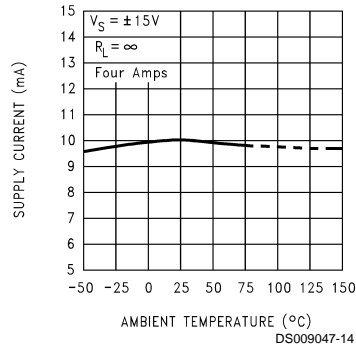
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# Typical Performance Characteristics (Continued)

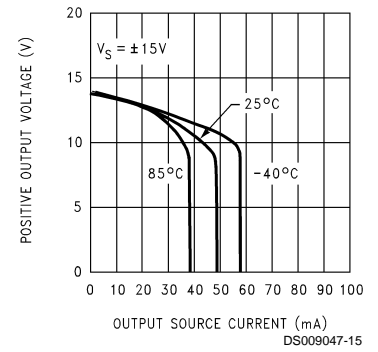
## Supply Current vs Supply Voltage



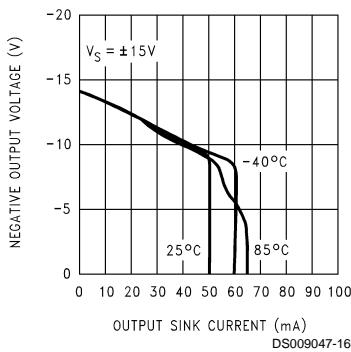
## Supply Current vs Ambient Temperature



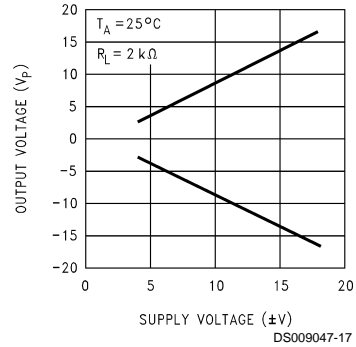
## Positive Current Limit



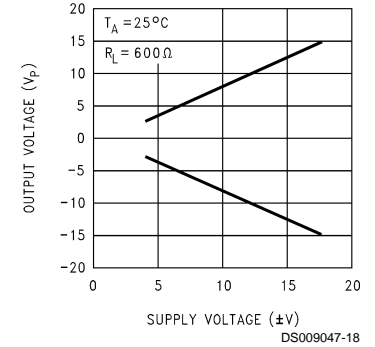
## Negative Current Limit



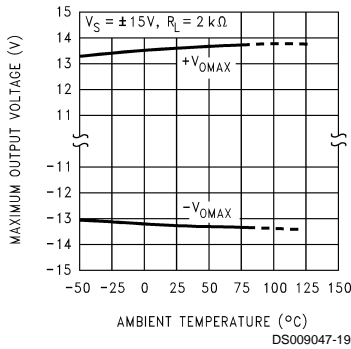
## Maximum Output Voltage vs Supply Voltage



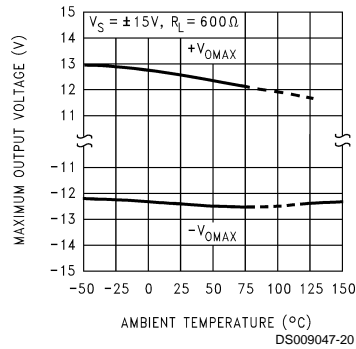
## Maximum Output Voltage vs Supply Voltage



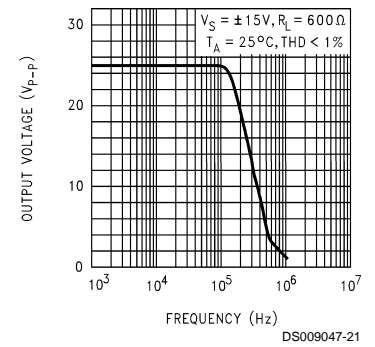
## Maximum Output Voltage vs Ambient Temperature



## Maximum Output Voltage vs Ambient Temperature

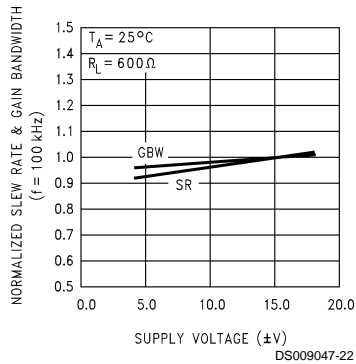


## Power Bandwidth

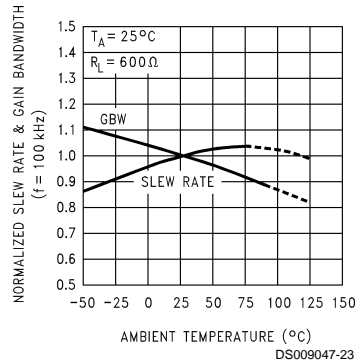


# Typical Performance Characteristics (Continued)

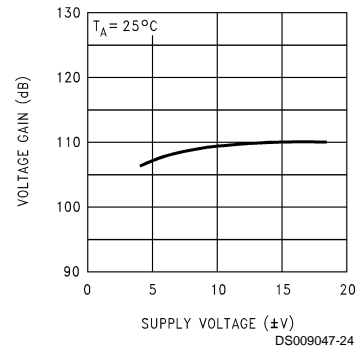
**Normalized Slew Rate & Gain Bandwidth vs Supply Voltage ( $f = 100$  kHz)**



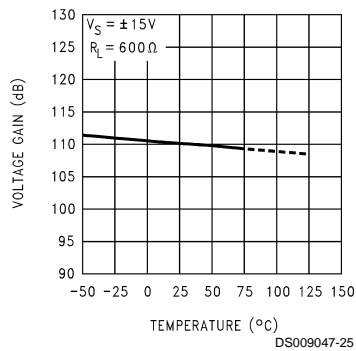
**Normalized Slew Rate & Gain Bandwidth ( $f = 100$  kHz) vs Ambient Temperature**



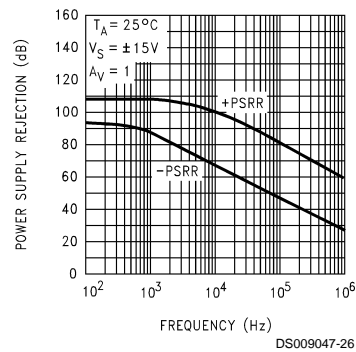
**Voltage Gain vs Supply Voltage**



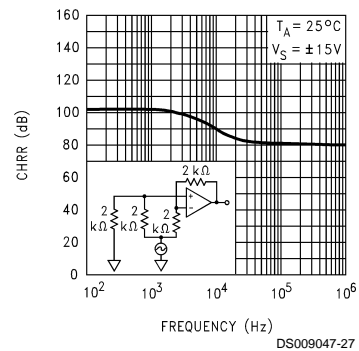
**Voltage Gain vs Ambient Temperature**



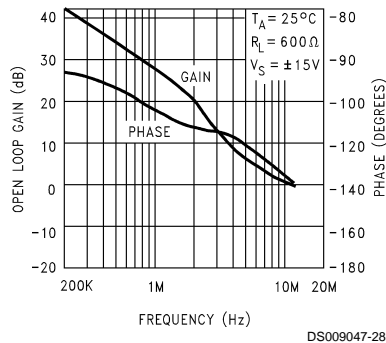
**Power Supply Rejection vs Frequency**



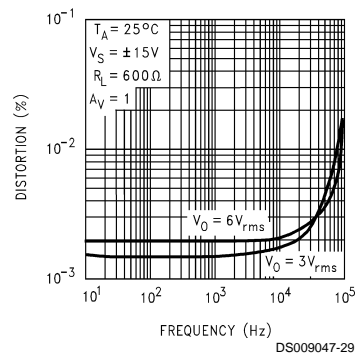
**CMRR vs Frequency**



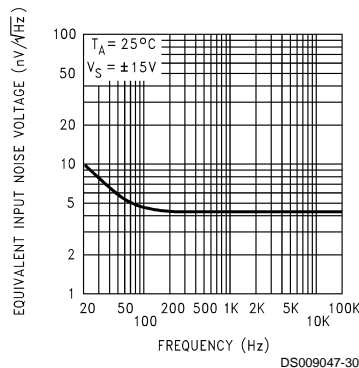
**Open Loop Gain & Phase vs Frequency**



**Total Harmonic Distortion vs Frequency**

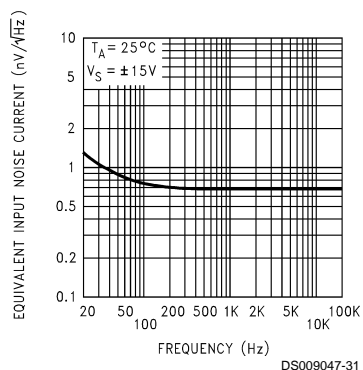


**Equivalent Input Noise Voltage vs Frequency**



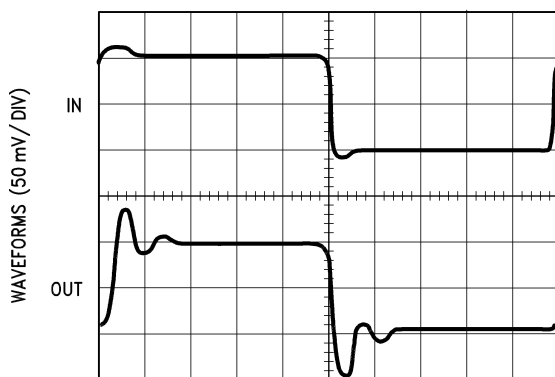
## Typical Performance Characteristics (Continued)

### Equivalent Input Noise Current vs Frequency



### Small Signal, Non-Inverting

$T_A = 25^\circ\text{C}$ ,  $A_V = 1$ ,  $R_L = 600\Omega$ ,  $V_S = \pm 15\text{V}$

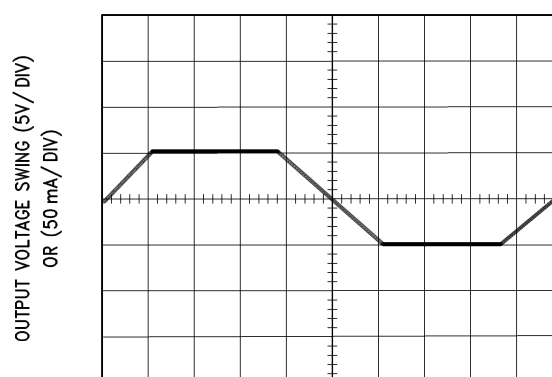


TIME (0.1  $\mu\text{s}$ /DIV)

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### Current Limit

$T_A = 25^\circ\text{C}$ ,  $V_S = \pm 15\text{V}$ ,  $R_L = 100\Omega$ ,  $A_V = 1$

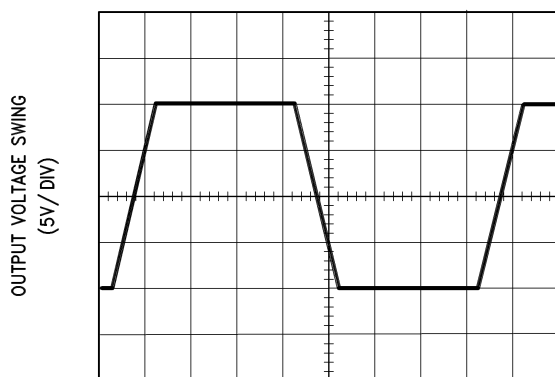


TIME (0.1 ms/DIV)

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### Large Signal Non-Inverting

$T_A = 25^\circ\text{C}$ ,  $R_L = 600\Omega$ ,  $V_S = \pm 15\text{V}$

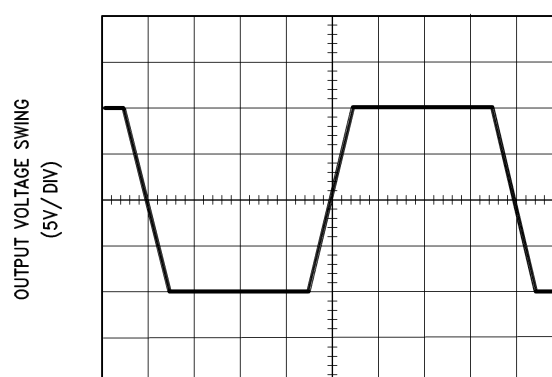


TIME (1  $\mu\text{s}$ /DIV)

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### Large Signal Inverting

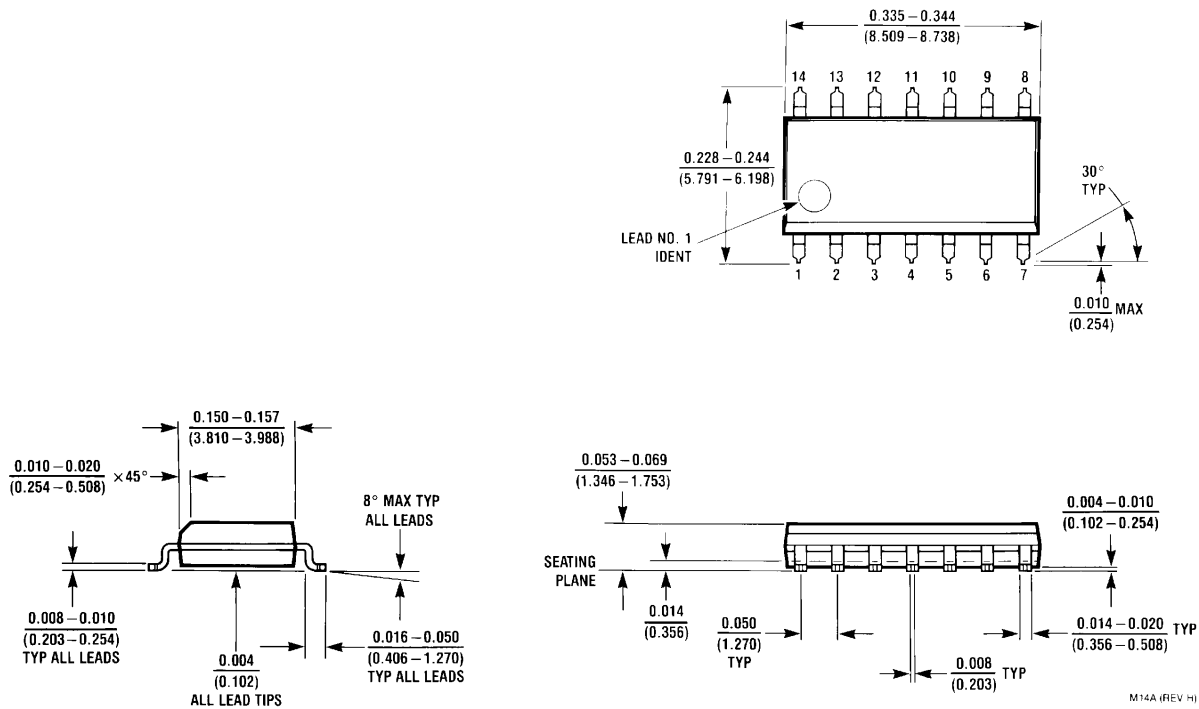
$T_A = 25^\circ\text{C}$ ,  $R_L = 600\Omega$ ,  $V_S = \pm 15\text{V}$



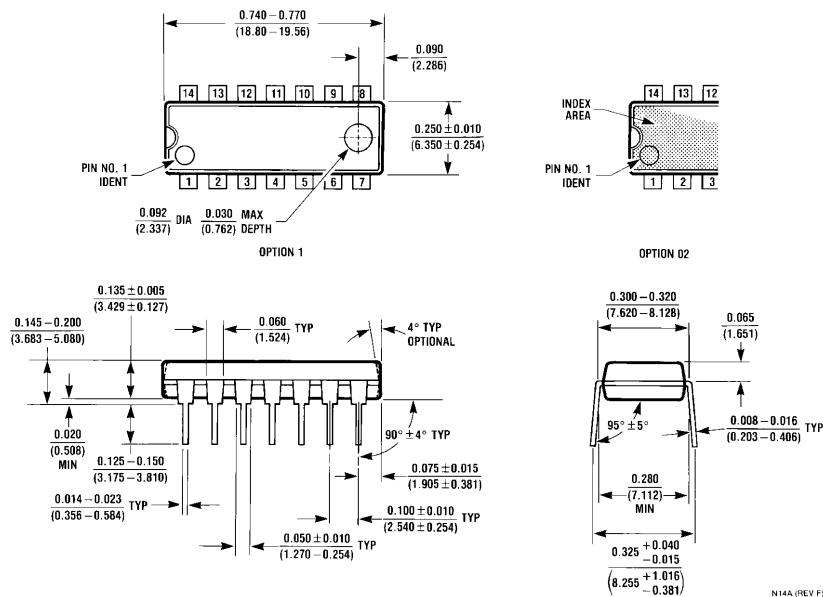
TIME (1  $\mu\text{s}$ /DIV)

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# Physical Dimensions inches (millimeters) unless otherwise noted



**Molded Package (SO)**  
**Order Number LM837M or LM837MX**  
**NS Package Number M14A**



**Lit. #107255**  
**Molded Dual-In-Line Package**  
**Order Number LM837N**  
**NS Package Number N14A**

## Notes

**LIFE SUPPORT POLICY**

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



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